

Soft Switching Series



Low Loss DuoPack : IGBT in **TrenchStop**[®] and Fieldstop technology with soft, fast recovery anti-parallel EmCon HE diode

- Short circuit withstand time 10μs
- Designed for :
 - Soft Switching Applications
 - Induction Heating
- TrenchStop[®] and Fieldstop technology for 1200 V applications offers :
 - very tight parameter distribution
 - high ruggedness, temperature stable behavior
 - easy parallel switching capability due to positive
 - temperature coefficient in V_{CE(sat)}
 - Very low V_{ce(sat)}
- Very soft, fast recovery anti-parallel EmCon[™] HE diode
- Low EMI
- Qualified according to JEDEC¹ for target applications
- Application specific optimisation of inverse diode
- Pb-free lead plating; RoHS compliant

Туре	V _{CE}	I _c	V _{CE(sat), Tj=25°C}	T _{j,max}	Marking	Package
IHP10T120	1200V	10A	1.7V	150°C	H10T120	PG-TO-220-3-1

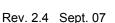
Maximum Ratings

Parameter	Symbol	Value	Unit
Collector-emitter voltage	V _{CE}	1200	V
DC collector current	I _C		А
$T_{\rm C} = 25^{\circ}{\rm C}$ $T_{\rm C} = 100^{\circ}{\rm C}$		16 10	
Pulsed collector current, t_p limited by T_{jmax}	I _{Cpuls}	24	
Turn off safe operating area $V_{CE} \le 1200V, T_j \le 150^{\circ}C$	-	24	
Diode forward current $T_{\rm C} = 25^{\circ}{\rm C}$ $T_{\rm C} = 100^{\circ}{\rm C}$	/ _F	11 7	
Diode pulsed current, t_p limited by T_{jmax} , $T_c = 25^{\circ}C$	I _{Fpuls}	16.5	
Diode surge non repetitive current, t_p limited by T_{jmax}	I _{FSM}		А
$T_{\rm C}$ = 25°C, t _p = 10ms, sine halfwave		28	
$T_{\rm C}$ = 25°C, t _p ≤ 2.5µs, sine halfwave		50	
$T_{\rm C}$ = 100°C, t _p \leq 2.5µs, sine halfwave		40	
Gate-emitter voltage	V _{GE}	±20	V
Short circuit withstand time ²⁾	t _{sc}	10	μS
$V_{\rm GE}$ = 15V, $V_{\rm CC} \le$ 1200V, $T_{\rm j} \le$ 150°C			
Power dissipation, $T_{\rm C} = 25^{\circ}{\rm C}$	P _{tot}	138	W
Operating junction temperature	Tj	-40+150	°C
Storage temperature	T _{stg}	-55+150	
Soldering temperature, 1.6mm (0.063 in.) from case for 10s	-	260	

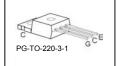
¹ J-STD-020 and JESD-022

²⁾ Allowed number of short circuits: <1000; time between short circuits: >1s.

Power Semiconductors









Thermal Resistance

Parameter	Symbol	Conditions	Max. Value	Unit
Characteristic				· ·
IGBT thermal resistance,	R _{thJC}		0.9	K/W
junction – case				
Diode thermal resistance,	R _{thJCD}		2.6	
junction – case				
IGBT thermal resistance,	R _{thJA}		62	
junction – ambient				

Electrical Characteristic, at T_i = 25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value			Unit
Parameter	Symbol	Conditions	min.	typ.	max.	Unit
Static Characteristic						
Collector-emitter breakdown voltage	$V_{(BR)CES}$	V_{GE} =0V, I_{C} =0.5mA	1200	-	-	V
Collector-emitter saturation voltage	$V_{CE(sat)}$	$V_{\rm GE}$ = 15V, $I_{\rm C}$ =10A				
		<i>T</i> _j =25°C	-	1.7	2.2	
		<i>T</i> _j =125°C	-	2.0	-	
		<i>T</i> _j =150°C	-	2.2	-	
Diode forward voltage	V _F	V_{GE} =0V, I_{F} =4A				
		<i>T</i> _j =25°C	-	1.65	2.15	
		<i>T</i> _j =150°C	-	1.7	-	
Gate-emitter threshold voltage	V _{GE(th)}	$I_{\rm C}$ =0.6mA, $V_{\rm CE}$ = $V_{\rm GE}$	5.0	5.8	6.5	
Zero gate voltage collector current	I _{CES}	V _{CE} =1200V, V _{GE} =0V				mA
		<i>T</i> _j =25°C	-	-	0.2	
		<i>T</i> _j =150°C	-	-	2.0	
Gate-emitter leakage current	I _{GES}	$V_{CE}=0V, V_{GE}=20V$	-	-	100	nA
Transconductance	${m g}_{\sf fs}$	V _{CE} =20V, <i>I</i> _C =10A	-	10	-	S
Integrated gate resistor	R _{Gint}			none		Ω



Dynamic Characteristic

Input capacitance	Ciss	V _{CE} =25V,	-	606	-	pF
Output capacitance	Coss	V _{GE} =0V,	-	48	-	
Reverse transfer capacitance	Crss	f=1MHz	-	29	-	
Gate charge	Q _{Gate}	V _{CC} =960V, <i>I</i> _C =10A	-	53	-	nC
		V _{GE} =15V				
Internal emitter inductance	L _E		-	13	-	nH
measured 5mm (0.197 in.) from case						
Short circuit collector current ¹⁾	I _{C(SC)}	V_{GE} =15V, t_{SC} ≤10µs V_{CC} = 600V, T_{j} = 25°C	-	48	-	A

Switching Characteristic, Inductive Load, at T_j =25 °C

Devenuetor	Cumple of	Conditions	Value			11	
Parameter	Symbol	Conditions	min.	typ.	max.	Unit	
IGBT Characteristic							
Turn-on delay time	t _{d(on)}	<i>T</i> _j =25°C,	-	45	-	ns	
Rise time	t _r	$V_{\rm CC}$ =610V, $I_{\rm C}$ =10A,	-	20	-		
Turn-off delay time	$t_{d(off)}$	V _{GE} = 0/15V, R _G =81Ω,	-	520	-		
Fall time	t _f	$L_{\sigma}^{2)}$ =180nH, $C_{\sigma}^{2)}$ =39pF	-	82	-		
Turn-on energy	Eon		-	0.68	-	mJ	
Turn-off energy	E _{off}	Energy losses include "tail" and diode	-	0.78	-		
Total switching energy	Ets	reverse recovery.	-	1.46	-		
Anti-Parallel Diode Characteristic							
Diode reverse recovery time	t _{rr}	<i>T</i> _j =25°C,	-	115	-	ns	
Diode reverse recovery charge	Q _{rr}	V _R =800V, <i>I</i> _F =4A,	-	330		nC	
Diode peak reverse recovery current	I _{rrm}	di _F /dt=750A/µs	-	7.15		А	

¹⁾ Allowed number of short circuits: <1000; time between short circuits: >1s. ²⁾ Leakage inductance L_{σ} and Stray capacity C_{σ} due to dynamic test circuit in Figure E.



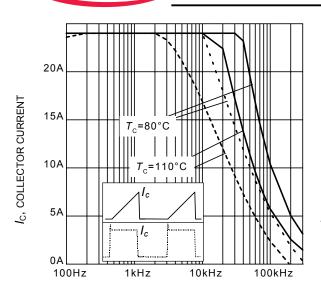
Switching Characteristic, Inductive Load, at T_i =150 °C

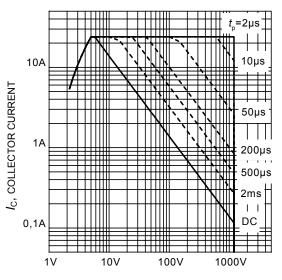
Poromotor	Symbol	Conditions	Value			Unit	
Parameter	Symbol Conditions		min.	typ.	max.	Unit	
IGBT Characteristic							
Turn-on delay time	$t_{d(on)}$	<i>T</i> _j =150°C,	-	45	-	ns	
Rise time	t _r	$V_{CC} = 610V, I_{C} = 10A,$ $V_{GE} = 0 / 15V,$	-	24	-		
Turn-off delay time	$t_{d(off)}$	$R_{\rm G}$ = 81Ω $L_{\sigma}^{(1)}$ =180nH, $C_{\sigma}^{(1)}$ =39pF	-	592	-		
Fall time	t _f		-	177	-		
Turn-on energy	Eon		-	0.83	-	mJ	
Turn-off energy	$E_{\rm off}$	Energy losses include "tail" and diode	-	1.19	-		
Total switching energy	E _{ts}	reverse recovery.	-	2.02	-		
Anti-Parallel Diode Characteristic							
Diode reverse recovery time	t _{rr}	<i>T</i> _j =150°C	-	185	-	ns	
Diode reverse recovery charge	Q _{rr}	V _R =800V, <i>I</i> _F =4A,	-	630	-	nC	
Diode peak reverse recovery current	<i>I</i> _{rrm}	di _F /dt=750A/µs	-	8.1	-	А	

 $^{^{1)}}$ Leakage inductance L $_{\sigma}$ and Stray capacity C $_{\sigma}$ due to dynamic test circuit in Figure E.



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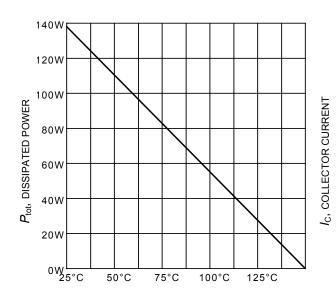




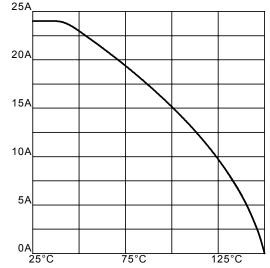
 $(T_j \le 150^{\circ}\text{C}, D = 0.5, V_{\text{CE}} = 600\text{V}, V_{\text{GE}} = 0/+15\text{V}, R_{\text{G}} = 81\Omega)$



 $(D = 0, T_{\rm C} = 25^{\circ}{\rm C}, T_{\rm i} \le 150^{\circ}{\rm C}; V_{\rm GE} = 15{\rm V})$



 $\label{eq:tau} \begin{array}{l} {\cal T}_{C}, \mbox{ CASE TEMPERATURE} \\ \mbox{Figure 3. Power dissipation as a function} \\ \mbox{ of case temperature} \\ ({\cal T}_{i} \leq 150^{\circ}C) \end{array}$



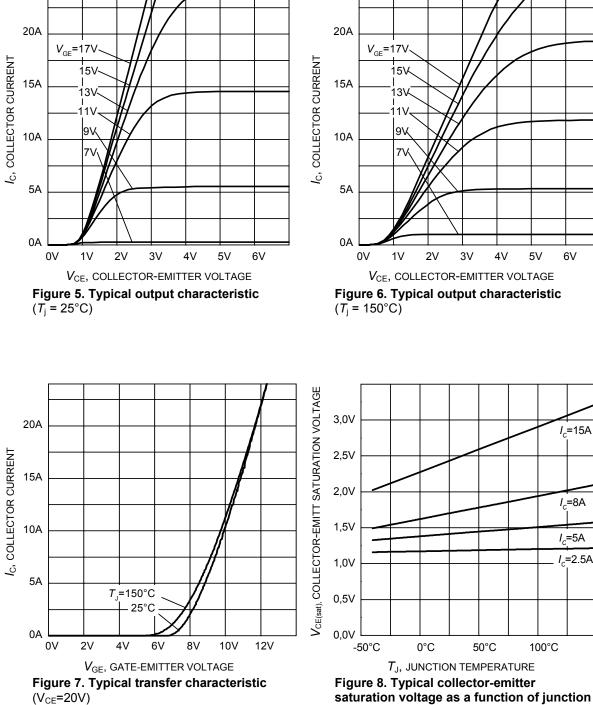
 $\label{eq:tau} T_{C}, \mbox{ CASE TEMPERATURE} \\ \mbox{Figure 4. Collector current as a function of } \\ \mbox{ case temperature} \\ (V_{GE} \geq 15V, \ T_{j} \leq 150^{\circ}C) \\ \end{cases}$



6V

I_=15A

I_=8A



saturation voltage as a function of junction temperature

 $(V_{\rm GE} = 15V)$



Soft Switching Series

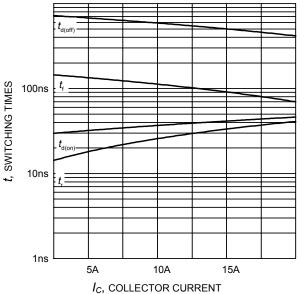
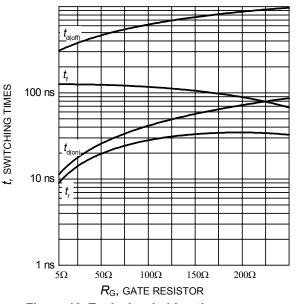


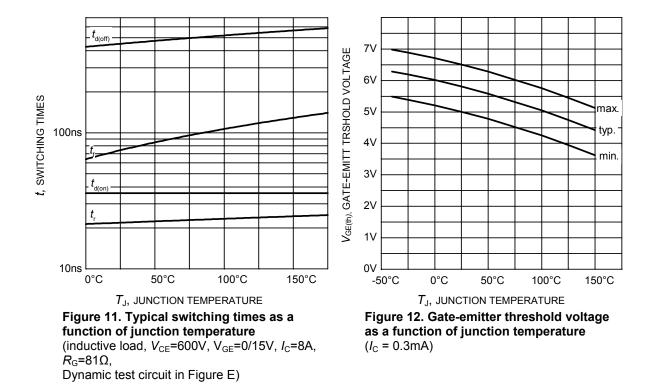
Figure 9. Typical switching times as a function of collector current (inductive load, T_J =150°C, V_{CE} =600V, V_{GE} =0/15V, R_G =81 Ω , Dynamic test circuit in Figure E)



IHP10T120

Figure 10. Typical switching times as a function of gate resistor (inductive load, T_J =150°C, V_{CE} =600V, V_{GE} =0/15V, I_C =8A,

Dynamic test circuit in Figure E)





Soft Switching Series

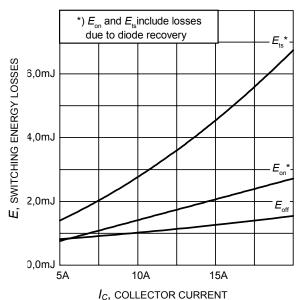


Figure 13. Typical switching energy losses as a function of collector current (inductive load, T_J =150°C, V_{CE} =600V, V_{GE} =0/15V, R_G =81 Ω , Dynamic test circuit in Figure E)

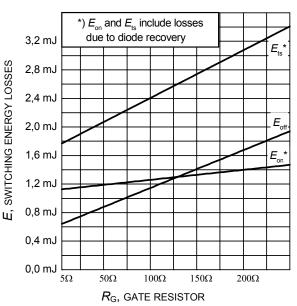


Figure 14. Typical switching energy losses as a function of gate resistor (inductive load, T_J =150°C, V_{CE} =600V, V_{GE} =0/15V, I_C =8A, Dynamic test circuit in Figure E)

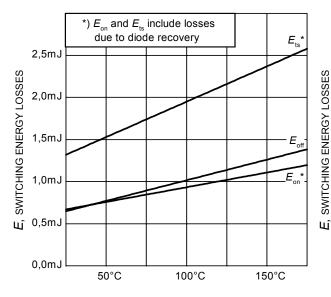
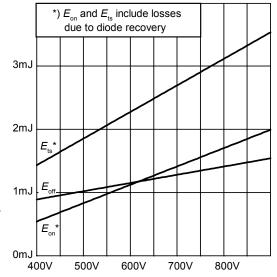




Figure 15. Typical switching energy losses as a function of junction temperature (inductive load, V_{CE} =600V, V_{GE} =0/15V, I_{C} =8A, R_{G} =81 Ω , Dynamic test circuit in Figure E)



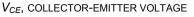


Figure 16. Typical switching energy losses as a function of collector emitter voltage (inductive load, T_J =150°C, V_{GE} =0/15V, I_C =8A, R_G =81 Ω , Dynamic test circuit in Figure E)



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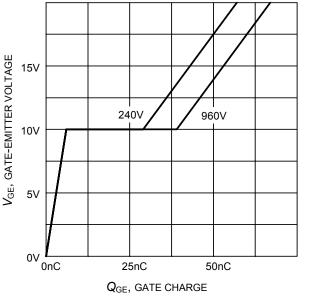


Figure 17. Typical gate charge $(I_{\rm C}$ =8 A)

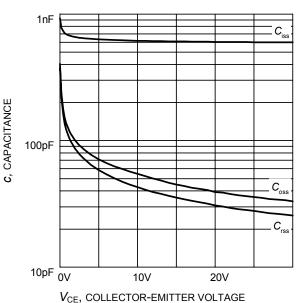
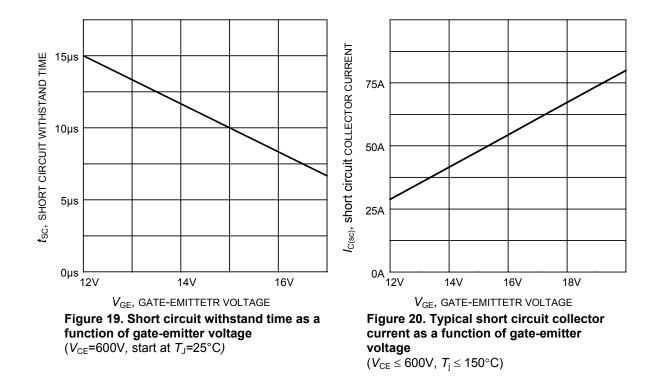


Figure 18. Typical capacitance as a function of collector-emitter voltage

(*V*_{GE}=0V, *f* = 1 MHz)





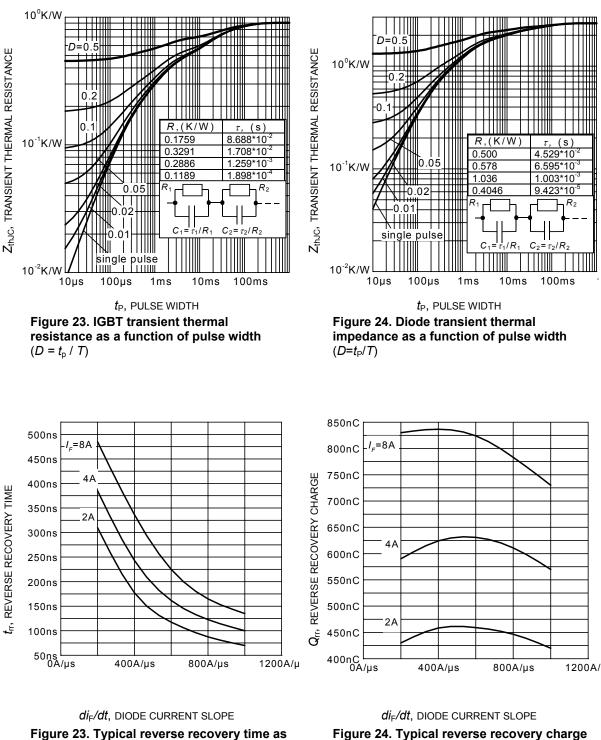


Figure 24. Typical reverse recovery charge as a function of diode current slope $(V_R=800V, T_J = 125^{\circ}C,$ Dynamic test circuit in Figure E)

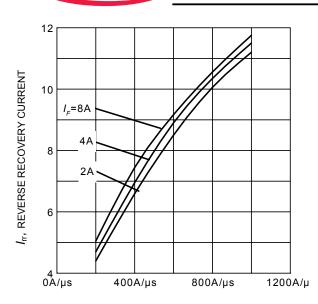
(V_R=600V, I_F=8A,

a function of diode current slope

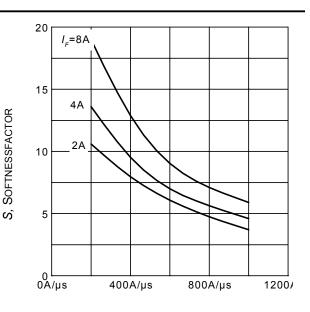
Dynamic test circuit in Figure E)



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 $di_{\rm F}/dt$, DIODE CURRENT SLOPE **Figure 25. Typical reverse recovery current as a function of diode current slope** ($V_{\rm R}$ =800V, $T_{\rm J}$ = 125°C, Dynamic test circuit in Figure E)



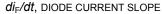


Figure 26. Typical reverse recovery softness factor as a function of diode current slope $(V_R=800V, T_J = 125^{\circ}C,$

Dynamic test circuit in Figure E)

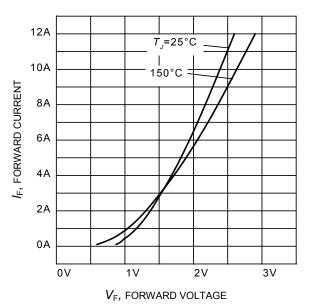
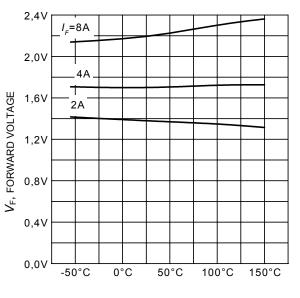
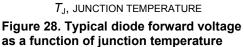


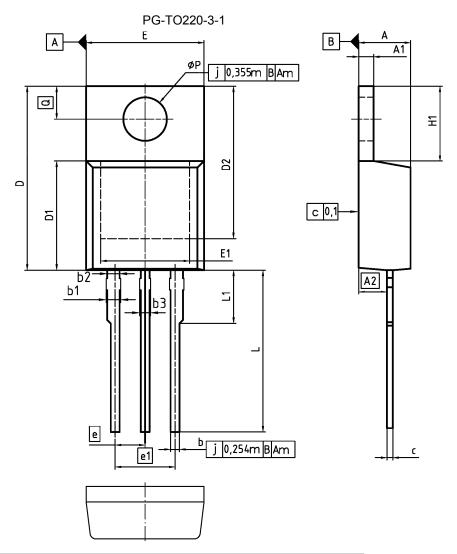
Figure 27. Typical diode forward current as a function of forward voltage



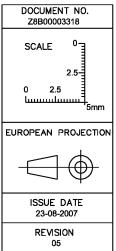








DIM	MILLIM	ETERS	INCH	IES]
DIM	MIN	MAX	MIN	MAX	
A	4.30	4.57	0.169	0.180	
A1	1.17	1.40	0.046	0.055	1
A2	2.15	2.72	0.085	0.107	
Ь	0.65	0.86	0.026	0.034	
Ь1	0.95	1.40	0.037	0.055	
b2	0.95	1.15	0.037	0.045	1
b3	0.65	1.15	0.026	0.045]
с	0.33	0.60	0.013	0.024	1
D	14.81	15.95	0.583	0.628	
D1	8.51	9.45	0.335	0.372	1
D2	12.19	13.10	0.480	0.516	
E	9.70	10.36	0.382	0.408	1
E1	6.50	8.60	0.256	0.339	1
е	2.5	54	0.1	00	1
e1	5.0	8	0.200		1
N	:	3	:	3	1
H1	5.90	6.90	0.232	0.272	1
L	13.00	14.00	0.512	0.551	1
L1	-	4.80	-	0.189	1
øP	3.60	3.89	0.142	0.153	1
Q	2.60	3.00	0.102	0.118	1



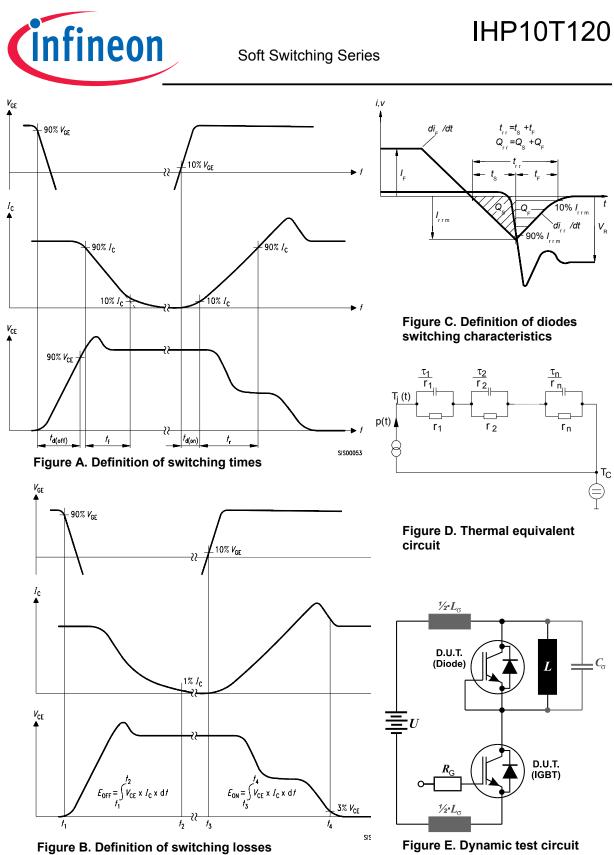


Figure E. Dynamic test circuit Leakage inductance L_{σ} =180nH and Stray capacity C_{σ} =39pF.



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